INTERNATIONAL STANDARD

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AMENDMENT 1 2003-11-15

Identification cards — Integrated circuit(s) cards with contacts —

Part 1: Physical characteristics

iTeh STAMENDMENT 1: Maximum height of the IC contact surface (standards.iteh.ai)

Is Cartes d'identification ___Cartes à circuit(s) intégré(s) à contacts —

https://standards.iteh. Partie g/stCaractéristiques physiques 2-817b-

ece88bd63ba6/iso-iec-7816-1-1998-and-1-2003 AMENDEMENT 1: Hauteur maximale de la surface des contacts de la carte IC



Reference number ISO/IEC 7816-1:1998/Amd.1:2003(E)

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The main task of the joint technical committee is to prepare International Standards. Draft International Standards adopted by the joint technical committee are circulated to national bodies for voting. Publication as an International Standard requires approval by at least 75 % of the national bodies casting a vote.

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Amendment 1 to ISO/IEC 7816-1:1998 was prepared by Technical Committee ISO/IEC/TC JTC 1, Information technology, Subcommittee SC 17, Cards and personal identification

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Part 1: **Physical characteristics**

AMENDMENT 1: Maximum height of the IC contact surface

Replace the subclause 4.2.3 with:

4.2.3 Surface profile of contacts

No point of the entire IC contact surface shall be higher than 0,10 mm above or lower than 0,10 mm below the adjacent surface of the card.

Within the range of the tolerances defined in this amendment, the card issuer may require more stringent tolerances in accordance with its sector or its application specific requirements. NJJ

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11 en SIA WARNING For cards which are printed after embedding, problems may be encountered when contacts are above the adjacent surface of the carditen.al

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